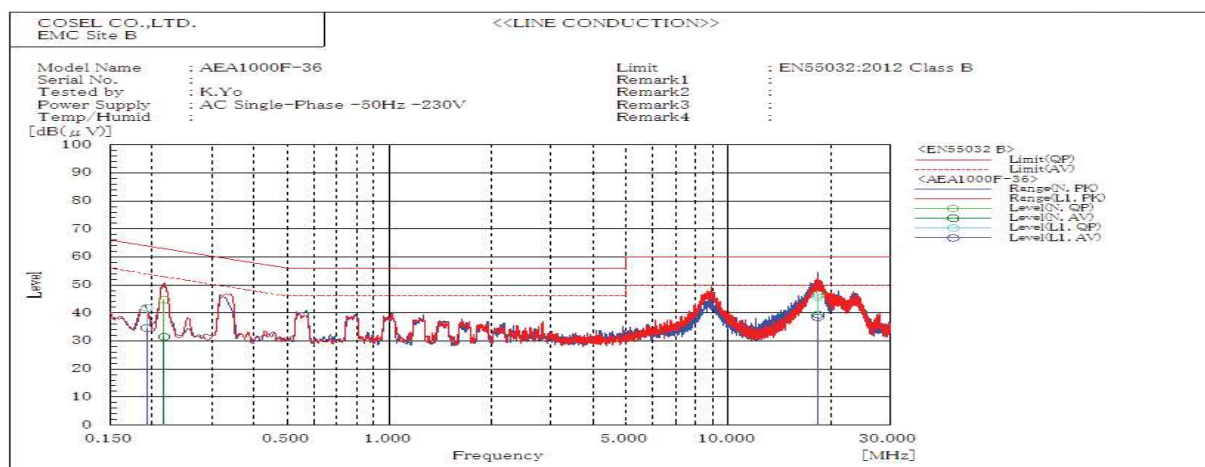
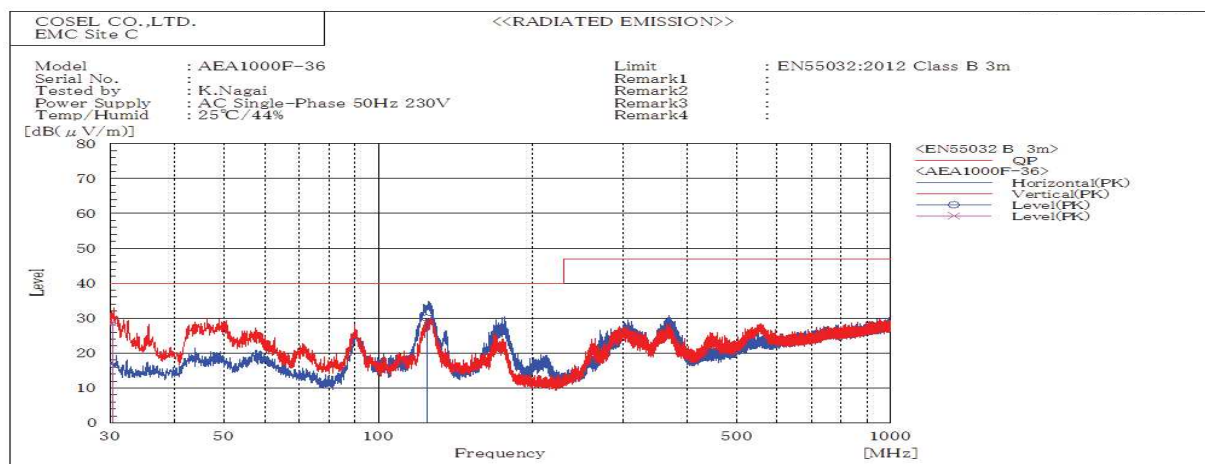


DATA SHEET		Date	12-Oct-21
Model	AEA1000F-36	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	44 %RH
		Tested by	K.Nagai



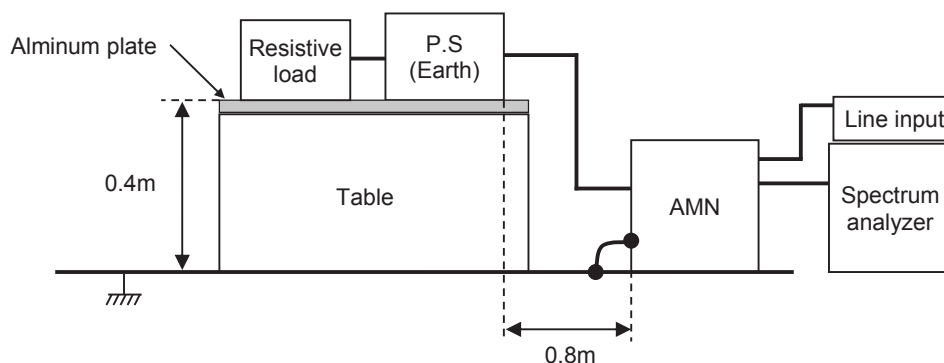
Frequency MHz	Line	Level dB(μV)		Limit dB(μV)		Margin dB		Pass/Fail	Remark
		QP	AV	QP	AV	QP	AV		
0.193	L1	41.9	34.6	63.9	53.9	22	19.3	Pass	
18.338	L1	45.7	38.5	60	50	14.3	11.5	Pass	
0.217	N	44.8	31.5	62.9	52.9	18.1	21.4	Pass	
18.366	N	46.6	39.4	60	50	13.4	10.6	Pass	



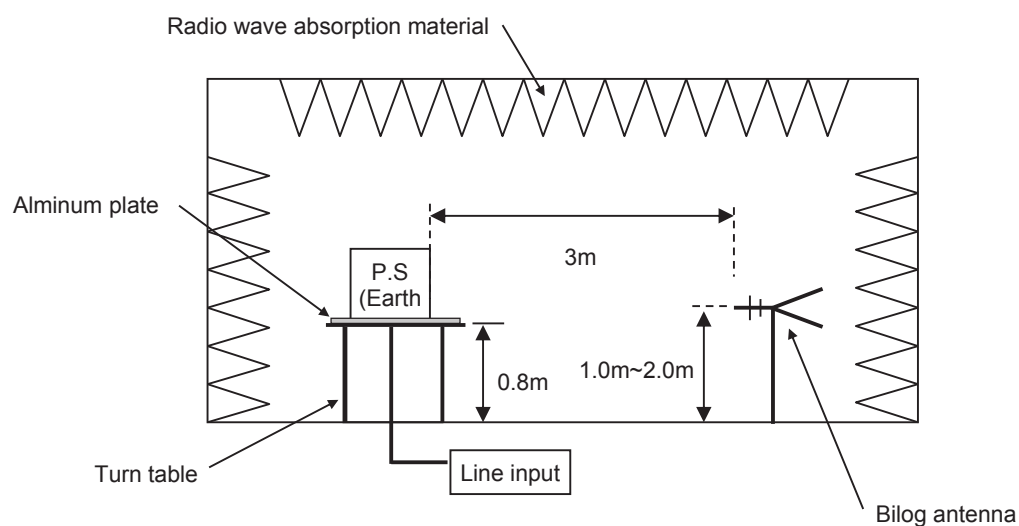
Frequency MHz	Polarization	Stability	Level dB(μV/m)		Limit dB(μV/m)	Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP	QP						
124.457	H	Stable	30	40	10	Pass	198.4	0		
30.332	V	Stable	29	40	11	Pass	100	42.4		

DATA SHEET		Date	12-Oct-21
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	44 %RH
		Tested by	K.Nagai

1. Line conduction



2. Radiated emission

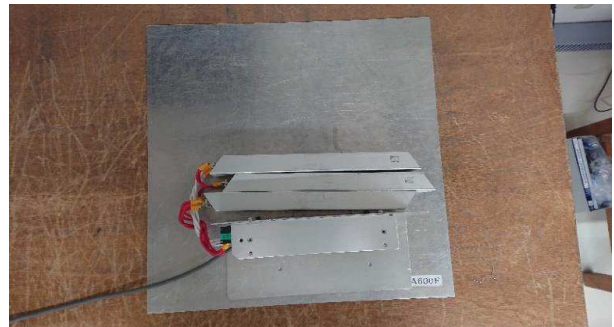


Conditions

Test : EMI
Model Name : AEA1000F

○Photographs of Test Set-Up

1.LINE CONDUCTION



2.RADIATED EMISSION

